

FDA032N08 N-Channel PowerTrench[®] MOSFET 75V, 235A, 3.2mΩ

Features

- $R_{DS(on)} = 2.5m\Omega$ (Typ.)@ $V_{GS} = 10V$, $I_D = 75A$
- Fast Switching Speed
- Low Gate Charge
- High Performance Trench Technology for Extremely Low $R_{\text{DS}(\text{on})}$
- High Power and Current Handling Capability
- RoHS Compliant

Description

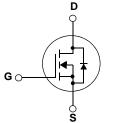
This N-Channel MOSFET is produced using Fairchild Semiconductor's adcanced PowerTrench process that has been especially tailored to minimize the on-state resistance and yet maintain superior switching performance.

Application

• DC to DC Convertors / Synchronous Rectification



TO-3PN



MOSFET Maximum Ratings T_C = 25°C unless otherwise noted*

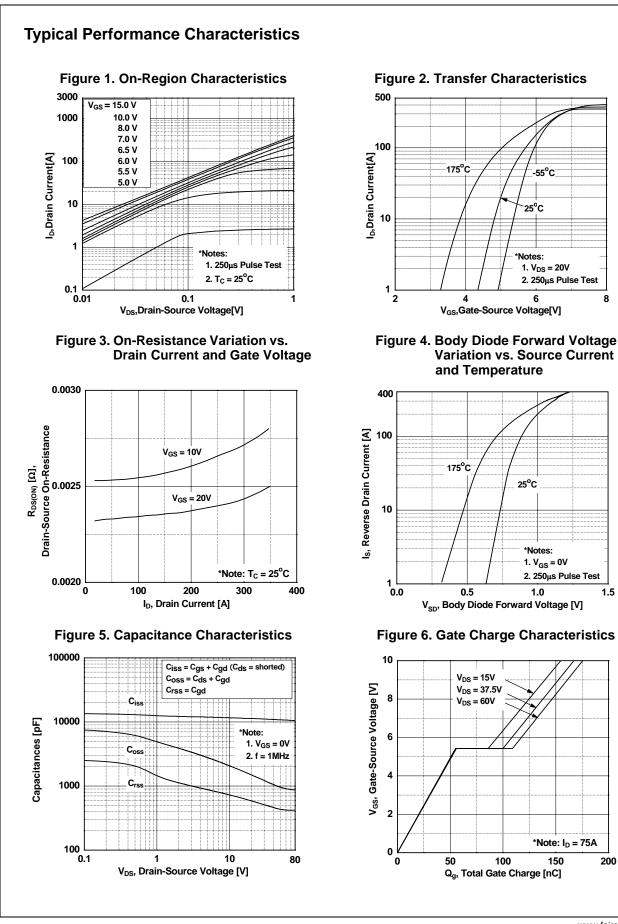
GDS

Symbol			FDA032N08	Units		
V _{DSS}	Drain to Source Voltage			75	V	
V _{GSS}	Gate to Source Voltage		±20	V		
I _D	DrainCurrent	-Continuous (T _C = 25°C, Silicon Lir	nited)	235*		
		-Continuous (T _C = 100°C, Silicon L	imited)	165*	А	
		-Continuous (T _C = 25°C, Package	Limited)	120		
I _{DM}	DrainCurrent	- Pulsed	- Pulsed (Note 1)		A	
E _{AS}	Single Pulsed Avalanche Energy (Note 2)		(Note 2)	1995	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3		(Note 3)	5.5	V/ns	
P _D	Power Dissipation	(T _C = 25°C)		375	W	
		- Derate above 25°C		2.5	W/ºC	
T _J , T _{STG}	Operating and Storage Temperature Range			-55 to +175	°C	
TL	Maximum Lead Temperature for Soldering Purpose, 1/8" from Case for 5 Seconds			300	°C	

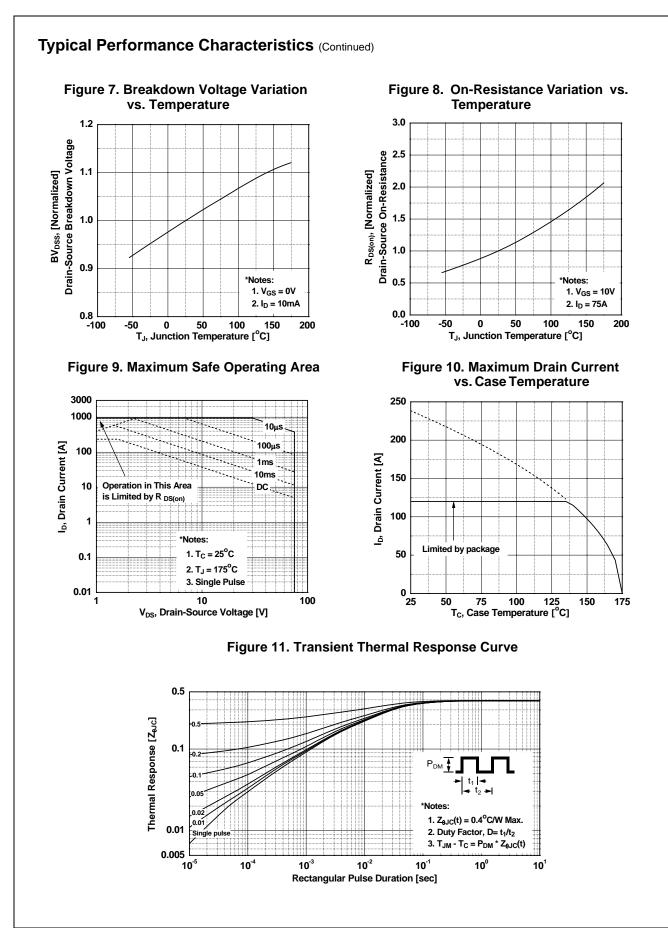
Symbol	Parameter	Ratings	Units
$R_{ ext{ heta}JC}$	Thermal Resistance, Junction to Case	0.4	
$R_{\theta CS}$	Thermal Resistance, Case to Sink Typ.	0.24	°C/W
$R_{ extsf{ heta}JA}$	Thermal Resistance, Junction to Ambient	40	

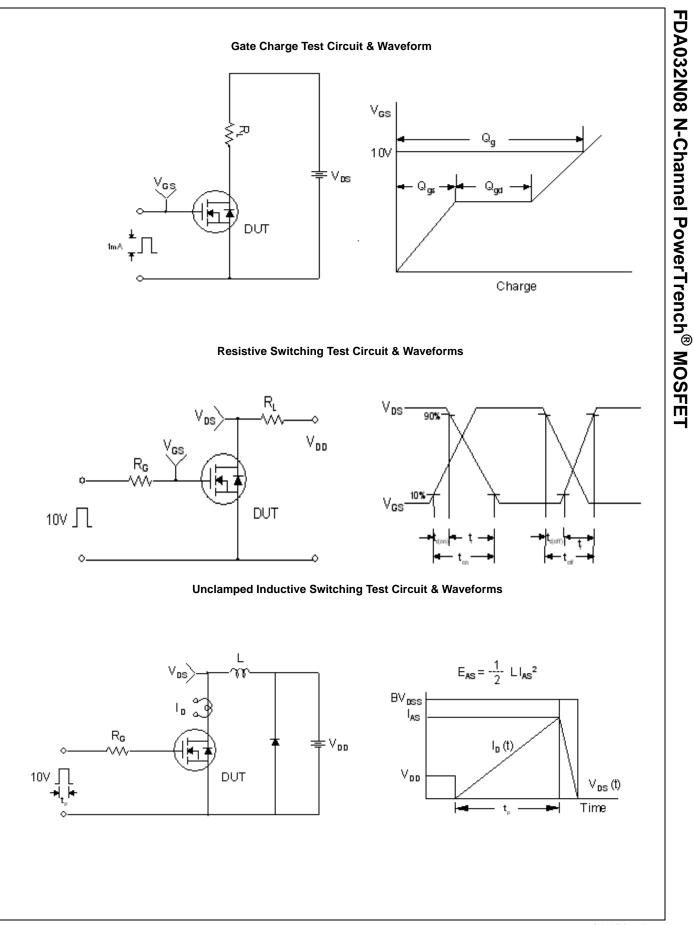
January 2009

Device Ma	arking	Device	Packag	je	Reel Size	Таре	e Width		Quantit	у
FDA032	N08	FDA032N08	TO-3P	N	-		-		30	
Electrica	l Char	acteristics								
Symbol	Parameter			Test Conditions		Min.	Тур.	Max.	Units	
Off Charac	teristic	S								
BV _{DSS}	Drain to	Drain to Source Breakdown Voltage		$I_{D} = 250 \mu A, V_{GS} = 0V, T_{C} = 25^{\circ}C$			75	-	-	V
ΔBV _{DSS} ΔT _J	Breakdown Voltage Temperature Coefficient		$I_D = 250 \mu A$, Referenced to $25^{\circ}C$			-	0.05	-	V/ºC	
I _{DSS}	Zero Gate Voltage Drain Current		ent	$V_{DS} = 75V, V_{GS} = 0V$ $V_{DS} = 75V, T_{C} = 150^{\circ}C$			-	-	1 500	μA
I _{GSS}	Gate to Body Leakage Current			-	±20V, V _{DS} = 0V		-	-	±100	nA
On Charac	teristic	S								
V _{GS(th)}	Gate Threshold Voltage		V _{GS} =	V _{DS} , I _D = 250μA		2.5	3.5	4.5	V	
R _{DS(on)}	Static D	Static Drain to Source On Resistance			10V, I _D = 75A		-	2.5	3.2	mΩ
9 _{FS}	Forward	orward Transconductance		$V_{DS} = 20V, I_D = 75A$ (Note 4)		-	180	-	S	
Dynamic C	haracte	eristics								
C _{iss}		apacitance	citance			-	11400	15160	pF	
C _{oss}	Output	Capacitance		────V _{DS} = 25V, V _{GS} = 0V f = 1MHz		-	1360	1810	pF	
C _{rss}	Reverse	e Transfer Capacitance)			-	595	800	pF	
Q _{g(tot)}	Total Ga	ate Charge at 10V		$V_{DS} = 60V, I_D = 75A$			-	169	220	nC
Q _{gs}	Gate to	Source Gate Charge					-	60	-	nC
Q _{gd}	Gate to	e to Drain "Miller" Charge		V _{GS} = 10V (Note 4, 5)		-	47	-	nC	
Switching	Charac	teristics								
t _{d(on)}	1	Delay Time					-	230	470	ns
t _r		n Rise Time		$V_{DD} = 37.5V, I_D = 75A$ $R_{GEN} = 25\Omega, V_{GS} = 10V$		-	191	392	ns	
t _{d(off)}	Turn-Of	f Delay Time				-	335	680	ns	
t _f	Turn-Of	f Fall Time		(Note 4, 5)			-	121	252	ns
Drain-Sour	ce Dioc	de Characteristic	s							
Is	Maximu	Maximum Continuous Drain to Source Diod		le Forward Current		-	-	235	Α	
SM	Maximu	m Pulsed Drain to Sou	rce Diode Fo	rward Cu	irrent		-	-	940	Α
V _{SD}	Drain to	Source Diode Forward	d Voltage	$V_{GS} = 0$	0V, I _{SD} = 75A		-	-	1.3	V
rr	Reverse	Recovery Time		$V_{GS} = 0V, I_{SD} = 75A$ $dI_F/dt = 100A/\mu s$ (No		_	-	53	-	ns
Q _{rr}	Reverse	Recovery Charge				(Note 4)	-	77	-	nC
. L = 0.71mH, I _{AS} . I _{SD} ≤ 75A, di/dt ≤ . Pulse Test: Pulse	= 75A, V _{DD} = ≦ 200A/μs, V _[e width ≤ 300	h limited by maximum junction = 50V, $R_G = 25\Omega$, Starting $T_J = 50D \le BV_{DSS}$, Starting $T_J = 25^{\circ}C$ $\mu\mu$ s, Duty Cycle $\le 2\%$ perating Temperature Typical (25°C							

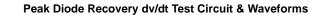


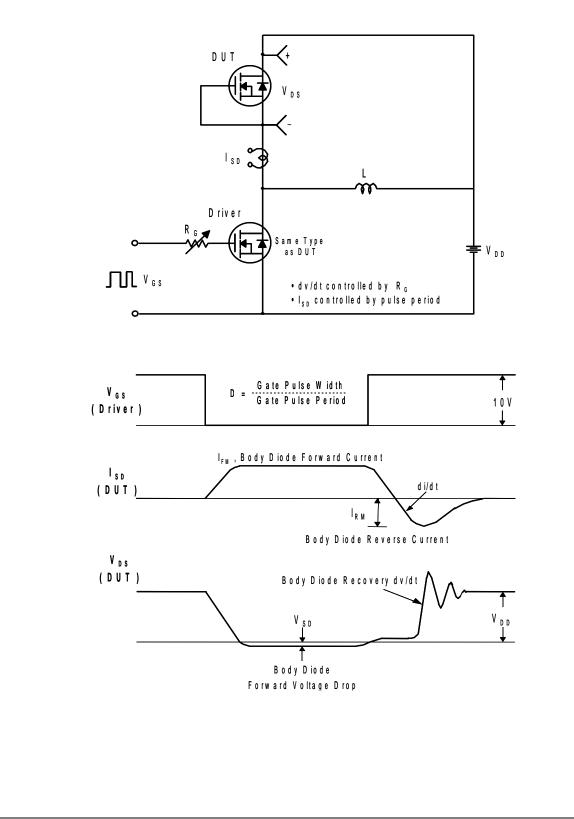
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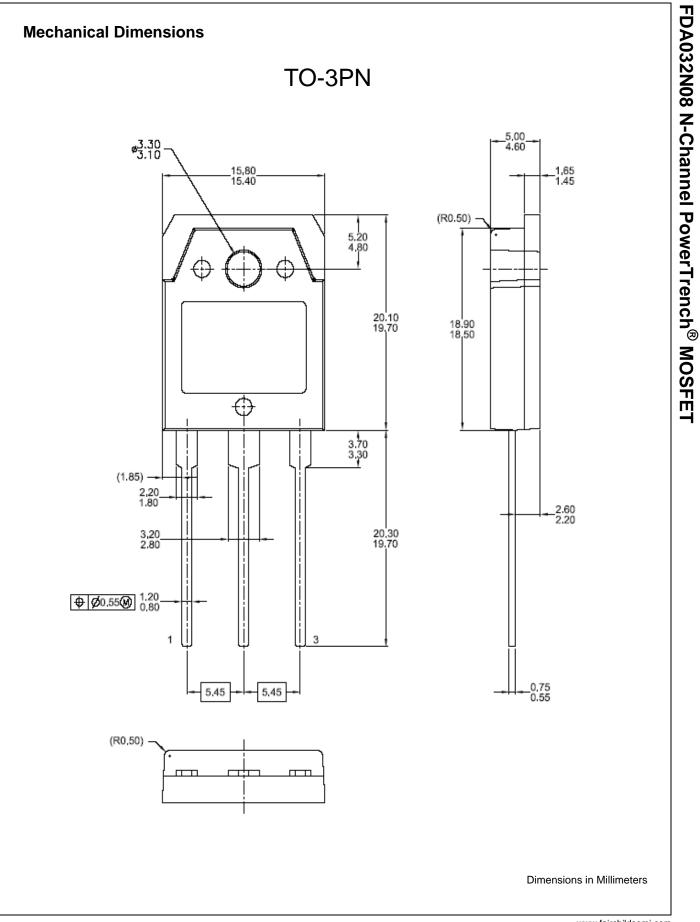




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